

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination DAY, MARK	
		Examiner Van Kim T. Nguyen	Art Unit 2151	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,904,600	06-2005	James et al.	719/328
	B	US-6,882,996	04-2005	Preisig et al.	707/4
	C	US-6,792,611	09-2004	Honishi et al.	719/328
	D	US-6,772,206	08-2004	Lowry et al.	709/223
	E	US-6,748,591	06-2004	Lewallen, Stephen Richard	717/170
	F	US-6,584,459	06-2003	Chang et al.	707/3
	G	US-2004/0199636	10-2004	Brown et al.	709/227
	H	US-2003/0074482	04-2003	Christensen et al.	709/313
	I	US-2002/0174178	11-2002	Stawikowski, Jean-Marie	709/203
	J	US-2002/0124113	09-2002	Gargya et al.	709/246
	K	US-2002/0116205	08-2002	Ankireddipally et al.	705/1
	L	US-2002/0073399	06-2002	Golden, Richard	717/114
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.